Search Notes

Application/Control No. 10/661,638	Applicant(s)/Patent under Reexamination
	HIRAIWA ET AL.
Examiner	Art Unit
Lois Zheng	1742

SEARCHED					
Class	Subclass	Date	Examiner		
204	287	2/2/2007	LLZ		
205	619	2/2/2007	LLZ		
205	620	2/2/2007	LLZ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	DATE	EXMR
inventorship search	2/2/2007	LLZ
Updated EAST search	2/2/2007	LLZ